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**Identification cards — Test methods —**  
**Part 6:**  
**Proximity cards**

*Cartes d'identification — Méthodes d'essai —*  
*Partie 6: Cartes de proximité*

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Reference number  
ISO/IEC 10373-6:2001(E)



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## Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 3.

In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC 1. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this part of ISO/IEC 10373 may be the subject of patent rights. ISO and IEC shall not be held responsible for identifying any or all such patent rights.

International Standard ISO/IEC 10373-6 was prepared by Joint Technical Committee ISO/IEC JTC 1, *Information technology*, Subcommittee SC 17, *Identification cards and related devices*.

ISO/IEC 10373 consists of the following parts, under the general title *Identification cards — Test methods*:

- *Part 1: General characteristics tests*
- *Part 2: Cards with magnetic stripes*
- *Part 3: Integrated circuit(s) cards with contacts and related interface devices*
- *Part 4: Close-coupled cards*
- *Part 5: Optical memory cards*
- *Part 6: Proximity cards*
- *Part 7: Vicinity cards*

Annexes A, C and D form a normative part of this part of ISO/IEC 10373. Annexes B, E and F are for information only.

# Identification cards — Test methods —

## Part 6: Proximity cards

### 1 Scope

This International Standard defines test methods for characteristics of identification cards according to the definition given in ISO/IEC 7810. Each test method is cross-referenced to one or more base standards, which may be ISO/IEC 7810 or one or more of the supplementary standards that define the information storage technologies employed in identification cards applications.

NOTE 1 Criteria for acceptability do not form part of this International Standard but will be found in the International Standards mentioned above.

NOTE 2 Test methods described in this International Standard are intended to be performed separately. A given card is not required to pass through all the tests sequentially.

This part of ISO/IEC 10373 deals with test methods which are specific to contactless integrated circuit(s) card technology (Proximity cards). ISO/IEC 10373-1, General characteristics, deals with test methods which are common to one or more ICC technologies and other parts deal with other technology-specific tests.

Unless otherwise specified, the tests in this part of ISO/IEC 10373 shall be applied exclusively to Proximity cards defined in ISO/IEC 14443-1 and ISO/IEC 14443-2.

### 2 Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this part of ISO 10373. For dated references, subsequent amendments to, or revisions of, any of these publications do not apply. However, parties to agreements based on this part of ISO 10373 are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. For undated references, the latest edition of the normative document referred to applies. Members of ISO and IEC maintain registers of currently valid International Standards.

ISO/IEC 7810:1995, *Identification cards — Physical characteristics*.

ISO/IEC 14443-1, *Identification cards — Contactless integrated circuit(s) cards — Proximity cards — Part 1: Physical characteristics*.

ISO/IEC 14443-2, *Identification cards — Contactless integrated circuit(s) cards — Proximity cards — Part 2: Radio frequency power and signal interface*.

ISO/IEC 14443-3, *Identification cards — Contactless integrated circuit(s) cards — Proximity cards — Part 3: Initialization and anticollision*.

IEC 61000-4-2: 1995, *Electromagnetic compatibility (EMC) — Part 4: Testing and measurement techniques — Section 2: Electrostatic discharge immunity test*.

BIPM, IEC, IFCC, ISO, IUPAC, IUPAP, OIML, 1993, *Guide to the Expression of Uncertainty in Measurement (Gum)*.